

Notice of References Cited

	Application/Control No.	Applicant(s)/Pate	nt Under	
09/966,968		Reexamination KWOK ET AL.		
	Examiner	Art Unit		
i	Paul F Brock II	2815	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-4,896,947	01-1990	Leenhouts, Frans	349/99
	В	US-4,995,704	02-1991	Yamamoto et al.	349/119
	С	US-5,702,640	12-1997	Junge et al.	252/299.1
	D	US-5,767,936	06-1998	Sugimura, Toshihiko	349/116
	E	US-5,764,316	06-1998	Takizawa et al.	349/1
	F	US-6,056,894	05-2000	Hirschmann et al.	252/299.63
	O	US-5,870,164	02-1999	Lu et al.	349/180
	Н	US-			
	+	US-			
	J	US-			
	Κ	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 02051125 A	02-1990	Japan	HANSU et al.	G02F 01/133
	0					
	Ρ					
	σ					
	R					
	s					
	۲					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	٧				
	w				
	х				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.